# **fime**

# **Mobile Card Test Platform**

Test application behavior, stored data and protocol handling on smart cards.



UICC, eUICC, USIM and SIM.

#### Overview.

The Mobile Card Test Platform is an advanced test tool for any smart card, UICC, eUICC, USIM, and SIM application developer or tester that wants to have a stable environment to perform repeatable tests.

#### Ensure the card functions correctly in all situations before launching it.

With this platform, you can test your card under development by simulating a mobile phone or M2M device. The simulation's behavior can be controlled and predicted. The platform enables to check whether a card responds as specified and expected in all possible scenarios before releasing it.

#### How it works.

The Mobile Card Test Platform simulates a mobile phone, M2M / IoT device, OTA platform and SM-SR. It enables the development of test scripts and automatic generation of test results.

#### Fime can help you at any stage of your project lifecycle.



### Key benefits

- · Quickly develop test scripts.
- · Provides off-the-shelf, fully automated test suites.
- · Rejects or accepts new cards quickly.
- Build your own test suites to streamline testing.
- Easy-to-use interface.

#### Key features

- Powerful and flexible API for test script development.
- · Ability to share exported test results with other interested parties using complimentary Mobile Log Viewer.
- · Support for SCP02, SCP03, SCP80 and SCP81 testing.
- Support for eUICC profile management and testing.
- · Use with Mobile Spy for fast debugging.
- Use with Remote Android Reader to test nonremovable SIM or eSIM in Android devices.

#### Libraries.

ETSITS	102 221, Smart Cards UICC-Terminal Interface Physical and Logical Characteristics
	102 223, Smart Cards Card Application Toolkit (CAT)
ETSI TS for SWP	ETSI TS 102 613, Smart Cards UICC - Contactless Front-end (CLF) Interface Part 1: Physical and data link layer characteristics
	ETSI TS 102 622, Smart Cards UICC - Contactless Front-end (CLF) Interface Host Controller Interface (HCI)
3GPP TS for GSM	51.011, Specification of the Subscriber Identity Module – Mobile Equipment (SIM-ME) Interface
	51.014, Specification of the SIM Application Toolkit for the Subscriber Identity Module - Mobile Equipment (SIM - ME) Interface
3GPP TS for 3G	31.101, UICC-Terminal Interface Physical and Logical Characteristics
	31.102, Characteristics of the Universal Subscriber Identity Module (USIM) Application
GlobalPlatform	GlobalPlatform Card Specification v2.3.1.
	GlobalPlatform Card Specification v2.2 – Amendment B, Remote Appli- cation Management over HTTP
	GlobalPlatform Card Specification v2.3.1 – Amendment C, Contactless Services
	GlobalPlatform Card Specification v2.2 – Amendment D, Secure Channel Protocol 03
	GlobalPlatform Card Specification v2.3.1 – Amendment E, Security Up- grade for Card Content Management

## 3GPP and ETSI Test Suites.

We also offer the **Mobile Card Test Suites**, off-theshelf, stand-alone card test suites that provide an efficient way of validating a card against relevant 3GPP and ETSI specifications:

- ETSI 102 230-2 and 3GPP 31.122 Test Suite.
- 3GPP 31.048 Test Suite (UICC).
- ETSI TS 102 268 and 3GPP 31.213 Test Suite.
- 3GPP 31.048 Test Suite (GSM).
- 3GPP 51.013 Test Suite.
- 3GPP 51.017 Test Suite.
- ETSI 103 481 Test Suite.
- ETSI 102 222 Test Suite.

#### Technical specifications.

- User-friendly GUI to write, compile and run scripts.
- Real-time view of file system (select, read and update functions).
- File system or I / O stream (translated or untranslated.
- Easy-to-read results that you can save and share.
- Convenient reports and details of the last run test.

Powerful Java APIs to help you develop your own test scripts and test suites:

- 3G API (includes 3G-5G functionality).
- GSM API.
- SWP API (includes SWP and HCI functionality).
- GlobalPlatform API.

#### Contact

To learn more about how Fime can help your business: fime.com sales@fime.com F-T-MOBILECARDTP-AC Test tool for Smart Cards, UICC, eUICC, USIM and SIM.